TOSHIBA Field Effect Transistor Silicon P Channel MOS Type (U-MOS II)

# **TPCS8102**

Lithium Ion Battery Applications Portable Equipment Applications Notebook PCs

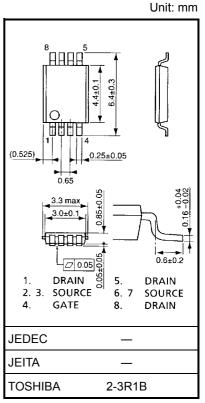
- Small footprint due to small and thin package
- Low drain-source ON resistance:  $RDS(ON) = 16 \text{ m}\Omega \text{ (typ.)}$
- High forward transfer admittance:  $|Y_{fs}| = 17 \text{ S (typ.)}$
- Low leakage current:  $I_{DSS} = -10 \mu A \text{ (max) (V}_{DS} = -20 \text{ V)}$
- Enhancement-mode:  $V_{th} = -0.5 \sim -1.2 \text{ V (VDS} = -10 \text{ V, ID} = -200 \text{ }\mu\text{A})$

## **Maximum Ratings (Ta = 25°C)**

Characte	ristics	Symbol	Rating	Unit	
Drain-source voltage		$V_{DSS}$	-20	V	
Drain-gate voltage (R	$k_{GS} = 20 \text{ k}\Omega$	$V_{DGR}$	-20	V	
Gate-source voltage		$V_{GSS}$	±12	V	
Drain current	DC (Note 1)	ΙD	-6	Α	
Drain current	Pulse (Note 1)	$I_{DP}$	-24	A	
Drain power dissipati	on (t = 10 s) (Note 2a)	$P_{D}$	1.5	W	
Drain power dissipati	on (t = 10 s) (Note 2b)	$P_{D}$	0.6	W	
Single pulse avalance	ne energy (Note 3)	E <sub>AS</sub>	46.8	mJ	
Avalanche current		I <sub>AR</sub>	-6	Α	
Repetitive avalanche	energy (Note 2a, Note 4)	E <sub>AR</sub>	0.15	mJ	
Channel temperature		T <sub>ch</sub>	150	°C	
Storage temperature	range	T <sub>stg</sub>	-55 to 150	°C	

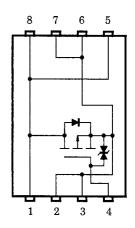
Note: For (Note 1), (Note 2), (Note 3) and (Note 4), please refer to the next page.

This transistor is an electrostatic sensitive device. Please handle with caution.



Weight: 0.035 g (typ.)

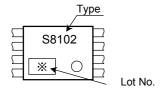
## **Circuit Configuration**



### **Thermal Characteristics**

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to ambient (t = 10 s) (Note 2a)	R <sub>th (ch-a)</sub>	83.3	°C/W
Thermal resistance, channel to ambient (t = 10 s) (Note 2b)	R <sub>th (ch-a)</sub>	208	°C/W

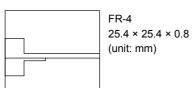
## Marking (Note 5)



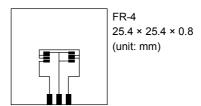
Note 1: Please use devices on condition that the channel temperature is below 150°C.

Note 2:

a) Device mounted on a glass-epoxy board (a)



b) Device mounted on a glass-epoxy board (b)



Note 3:  $V_{DD}$  = -16 V,  $T_{ch}$  = 25°C (initial), L = 1.0 mH,  $R_G$  = 25  $\Omega$ ,  $I_{AR}$  = -6.0 A

Note 4: Repetitive rating: pulse width limited by maximum channel temperature

Note 5: O on lower right of the marking indicates Pin 1.

Weekly code: (Three digits)

Week of manufacture
(01 for first week of year, continues up to 52 or 53)

Year of manufacture
(One low-order digits of calendar year)

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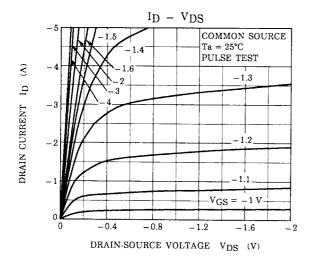
# Electrical Characteristics (Ta = 25°C)

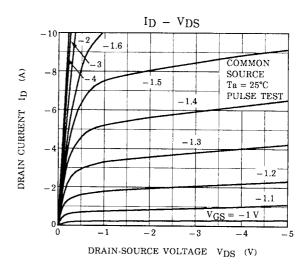
Chara	acteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage curi	rent	I <sub>GSS</sub>	V <sub>GS</sub> = ±10 V, V <sub>DS</sub> = 0 V	_	_	±10	μΑ
Drain cut-OFF cu	rrent	I <sub>DSS</sub>	V <sub>DS</sub> = -20 V, V <sub>GS</sub> = 0 V	_	_	-10	μΑ
Drain-source brea	akdown voltage	V (BR) DSS	I <sub>D</sub> = -10 mA, V <sub>GS</sub> = 0 V -20	-20	_	_	V
Drain-source breakdown voltage		V (BR) DSX	I <sub>D</sub> = -10 mA, V <sub>GS</sub> = 12 V	-8	_	_	·
Gate threshold vo	ltage	V <sub>th</sub>	$V_{DS} = -10 \text{ V}, I_D = -200 \mu\text{A}$	-0.5	_	-1.2	V
		R <sub>DS</sub> (ON)	$V_{GS} = -2.0 \text{ V}, I_D = -3 \text{ A}$		30	60	mΩ
Drain-source ON	resistance	R <sub>DS (ON)</sub>	$V_{GS} = -2.5 \text{ V}, I_D = -3 \text{ A}$		23	38	
		R <sub>DS (ON)</sub>	$V_{GS} = -4 \text{ V}, I_D = -3 \text{ A}$		16	20	
Forward transfer	ward transfer admittance $ Y_{fS} $ $V_{DS} = -10 \text{ V}, I_D = -3 \text{ A}$		$V_{DS} = -10 \text{ V}, I_D = -3 \text{ A}$	8.5	17		S
Input capacitance		C <sub>iss</sub>			2740		pF
Reverse transfer capacitance		C <sub>rss</sub>	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	_	780	_	pF
Output capacitance		Coss		_	1030	_	pF
Switching time	Rise time	t <sub>r</sub>	$V_{GS}$ $V_{OUT}$ $V_{OUT}$ $V_{OUT}$ $V_{OUT}$ $V_{OUT}$ $V_{DD}$ $V_{DD}$ $V_{DD}$ $V_{DD}$ $V_{DD}$ $V_{DD}$ $V_{DD}$ $V_{DD}$	_	7.6		
	Turn-ON time	t <sub>on</sub>		-	16		ns
	Fall time	t <sub>f</sub>			110		
	Turn-OFF time	t <sub>off</sub>		_	230	_	
Total gate charge (gate-source plus gate-drain)		Qg		_	37	_	nC
Gate-source charge		Q <sub>gs</sub>	$V_{DD} \approx -16 \text{ V}, V_{GS} = -5 \text{ V}, I_D = -6 \text{ A}$	_	27	_	nC
Gate-drain ("miller") charge		Q <sub>gd</sub>			10	_	nC

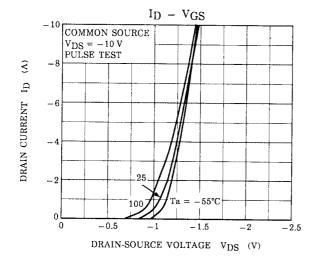
# **Source-Drain Ratings and Characteristics (Ta = 25°C)**

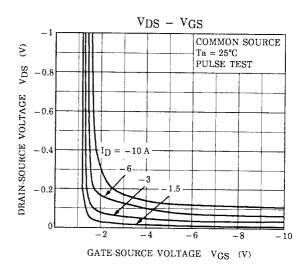
Charact	eristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	Pulse (Note 1)	I <sub>DRP</sub>		_		-24	Α
Forward voltage (	(diode)	V <sub>DSF</sub> I <sub>DR</sub> = -6 A, V <sub>GS</sub> = 0 V — —			1.2	V	

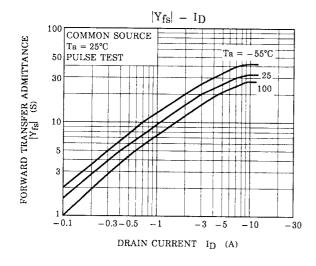
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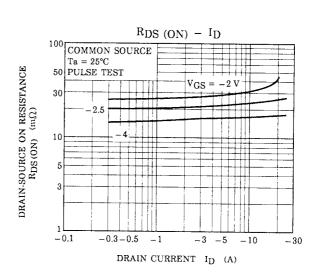




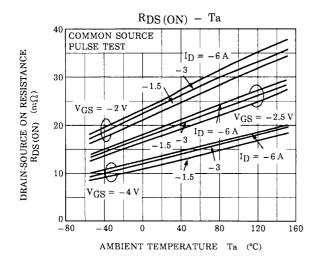


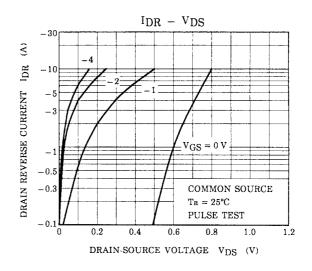


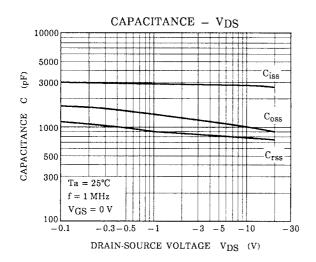


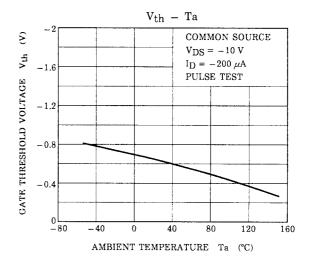


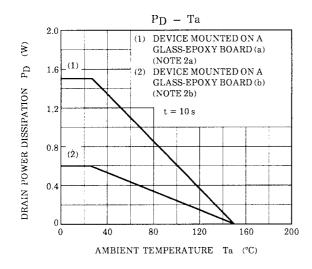
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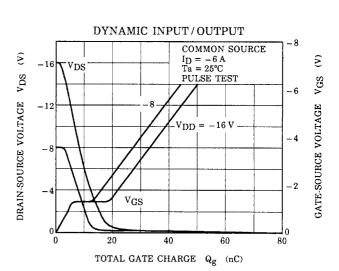




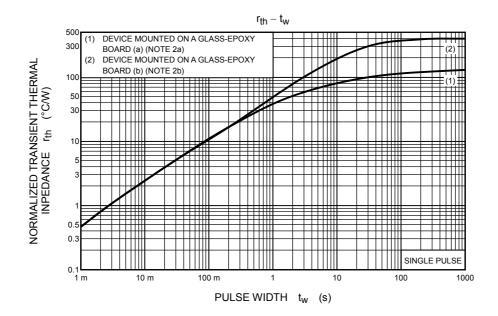


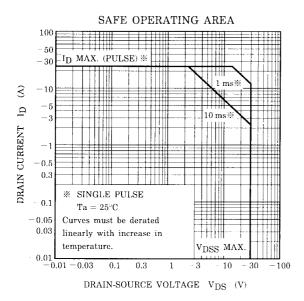


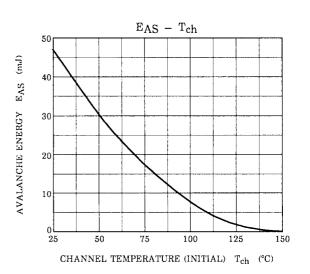


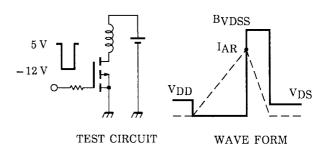


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$$\begin{array}{l} T_{ch}=25^{\circ}C~(\mathrm{Initial}) \\ Peak~I_{AR}=-6~A,~R_{G}=25~\Omega~~E_{AS}=\frac{1}{2}\cdot L~\cdot I^{2}\cdot~(\frac{BVDSS}{BVDSS-V_{DD}}) \\ V_{DD}=-16~V,~L=1.0~mH \end{array}$$

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